SUPERCONDUCTING DC AND RF PROPERTIES OF INGOT NIOBIUM

Pashupati Dhakal[#], Gianluigi Ciovati, Peter Kneisel, and Ganapati Rao Myneni

Jefferson Lab, Newport News, VA

ABSTRACT

The thermal conductivity, DC magnetization and penetration depth of large-grain niobium hollow cylindrical rods fabricated from ingots, manufactured by CBMM subjected to chemical and heat treatment were measured. The results confirm the influence of chemical and heat-treatment processes on the superconducting properties, with no significant dependence on the impurity concentrations in the original ingots. Furthermore, RF properties, such as the surface resistance and quench field of the niobium rods were measured using a TE₀₁₁ cavity. The hollow niobium rod is the center conductor of this cavity, converting it to a coaxial cavity. The quench field is limited by the critical heat flux through the rods' cooling channel.



	Ta	H	0	Ν	C	RRR
Samples						
F	1330	<1	<6	<3	<30	226±10
G	1375	7.1	<6	<3	<30	197± 8
Н	704	<1	<6	<3	<30	240± 9
Ι	708	5.4	<6	<3	<30	224±8

normal state.



The total thermal conductivity of a superconductor is sum of the electronic conduction due to the unpaired electrons and lattice thermal conductivity

TE₀₁₁ mode

B_p





Conclusions and Future Works

Acknowledgements

∠ 2K phonon peak in thermal conductivity due to the high temperature (HT) treatment. ∠ Improvement of surface critical field due to HT and low temperature baking (LTB). \swarrow RF measurement on TE₀₁₁ cavity shows the reduction of surface resistance and hence the increase in quality factor due to the chemical and heat treatment, however maximum peak magnetic field is limited due to the critical heat flux of the niobium rods. The further chemical treatment (EP), longer LTB and several combination of chemical and heat treatment are planned for future work in understanding the limiting factors of cavity performance and implementation of these results to new generation SRF cavities.

RF Properties

100 μm BCP

100 μm BCP+3hr@800°C+3hr@140°C

empty cavity •

0.5

0.4

 $1/T (K^{-1})$

 $B_{n}(mT)$

sample

B_p

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dhakal@jlab.org

